Search Notes



App	licatio	n/Con	trol	No.
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Applicant(s)/Patent under Reexamination

NAGAHAMA ET AL.

10/751,483

Examiner

Art Unit

Sonny TRINH

2618

SEARCHED					
Class	Subclass	Date	Examiner		
455	45,61	5/15/2006	ST		
455	3.01,203	5/15/2006	ST		
455	47,150.1	5/15/2006	ST		
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375	270	5/15/2006	ST		
375	301	5/15/2006	ST		
375	316	5/15/2006	ST		
375	277	5/15/2006	ST		
375	321	5/15/2006	ST		

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
U.S. Patent, EPO, JPO, DERWENT, PG-PUB	5/15/2006 ·	ST		